

<b>Notice of References Cited</b>	Application/Control No. 09/981,688		Applicant(s)/Patent Under Reexamination TANSKANEN ET AL.	
	Examiner X. L. Bautista		Art Unit 2179	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,222,520 B1	04-2001	Gerszberg et al.	715/784
*	B	US-5,796,967	08-1998	Filepp et al.	715/764
*	C	US-6,449,601 B1	09-2002	Friedland et al.	705/37
*	D	US-2004/0024610 A1	02-2004	Fradkov et al.	705/1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 000552822 A2	07-1993	EPO	Yves AUDEBERT et al	G06F 1/00
	O	JP 408194753 A	07-1996	JPO	Wataru YOSHIHARA et al	G06F 19/00
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.